

20V 2N-Channel Enhancement-Mode MOSFET

General Description

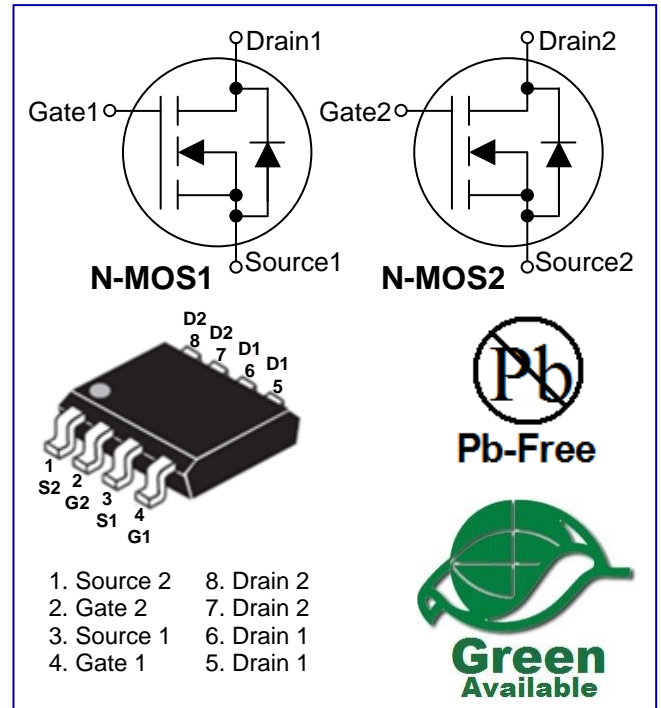
These 9926A dual N-Channel enhancement mode power field effect transistors in one package are using trench DMOS technology. This advanced technology has been especially tailored to minimize on-state resistance, provide superior switching performance, and withstand high energy pulse in the avalanche and commutation mode. These devices are well suited for high efficiency fast switching applications.

Features

- $V_{DS}=20V$
- $I_D=6A @ V_{GS}=4.5V$
- $R_{DS(on)}=46m\Omega(Typ.) @ V_{GS}=4.5V$
- $R_{DS(on)}=58m\Omega(Typ.) @ V_{GS}=2.5V$
- $R_{DS(on)}=80m\Omega(Typ.) @ V_{GS}=1.8V$
- Advanced high cell density Trench technology
- Improved dv/dt capability
- Fast switching
- High power and current handing capability
- Package: SOP-8
- Pb-Free and Green devices are available

Applications

- Load Switch
- Notebook
- Hand-Held Instruments



Absolute Maximum Ratings ($T_A=25^\circ C$ unless otherwise noted)

Parameter	Symbol	Limit	Unit
Drain-Source Voltage	V_{DS}	20	V
Gate-Source Voltage	V_{GS}	± 10	V
Drain Current ^a	I_D	$T_C=25^\circ C$	6
		$T_C=70^\circ C$	2.1
Drain Current –Pulsed ^a	I_{DM}	15.2	A
Power Dissipation ($T_C=25^\circ C$)	P_D	2.1	W
Power Dissipation – Derate Above $25^\circ C$		0.017	W/ $^\circ C$
Storage Temperature Range	T_{STG}	-55 ~ +150	$^\circ C$
Operating Junction Temperature Range	T_J	-55 ~ +150	$^\circ C$
Thermal Resistance, Junction-to-Ambient	$R_{\theta JA}$	62.5	$^\circ C/W$

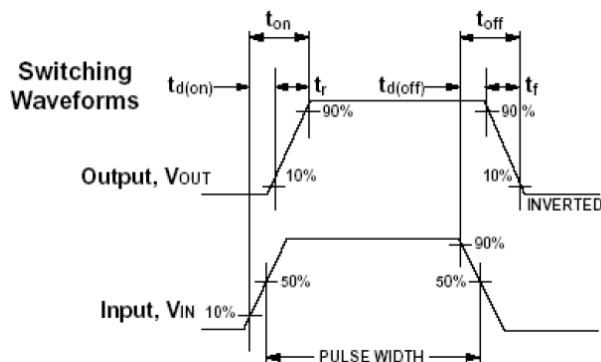
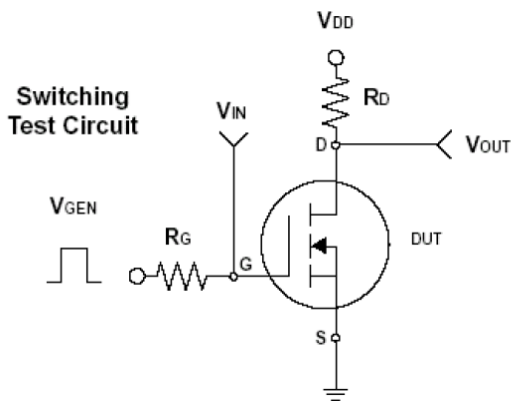
Electrical Characteristics ($T_A=25^\circ C$ unless otherwise noted)

Parameter	Symbol	Condition	Min	Typ	Max	Unit
Off Characteristics						
Drain-Source Breakdown Voltage	BV_{DSS}	$V_{GS}=0V, I_D=250\mu A$	20	---	---	V
Zero Gate Voltage Drain Current	I_{DSS}	$T_J=25^\circ C$	---	---	1	μA
		$T_J=125^\circ C$	---	---	10	μA
Gate-Body Leakage	I_{GSS}	$V_{GS}=\pm 10V, V_{DS}=0V$	---	---	± 100	nA
On Characteristics ^a						

Gate Threshold Voltage	$V_{GS(th)}$	$V_{DS}=V_{GS}, I_D=250\mu A$	0.3	---	1.0	V
Drain-Source On-State Resistance	$R_{DS(on)}$	$V_{GS}=4.5V, I_D=3.8A$	---	46	65	m Ω
		$V_{GS}=2.5V, I_D=3.0A$	---	58	80	
		$V_{GS}=1.8V, I_D=2.0A$	---	80	120	
Forward Transconductance	gfs	$V_{DS}=10V, I_D=2A$	---	4.4	---	S
Drain-Source Diode Characteristics ^a						
Continuous Source Current	I_S	$V_G=V_D=0V, \text{Force Current}$	---	---	6	A
Pulsed Source Current	I_{SM}		---	---	15.2	A
Diode Forward Voltage	V_{SD}	$V_{GS}=0V, I_S=1.0A, T_J=25^\circ C$	---	---	1.3	V
Dynamic Characteristics ^b						
Input Capacitance	C_{iss}	$V_{DS}=15V, V_{GS}=0V, F=1MHz$	---	180	360	pF
Output Capacitance	C_{oss}		---	32	64	
Reverse Transfer Capacitance	C_{rss}		---	26	52	
Switching Characteristics ^b						
Total Gate Charge	Q_g	$V_{DS}=10V, V_{GS}=4.5V, I_D=3.8A$	---	3.6	7.2	nC
Gate-Source Charge	Q_{gs}		---	0.38	0.76	
Gate-Drain Charge	Q_{gd}		---	0.6	1.2	
Turn-On Delay Time	$T_{d(on)}$	$V_{DD}=10V, V_{GS}=4.5V, R_G=25\Omega, I_D=1A$	---	1.8	5	ns
Rise Time	T_r		---	5.6	12	
Turn-Off Delay Time	$T_{d(off)}$		---	11.3	24	
Fall Time	T_f		---	3.2	7	

Notes: a. Repetitive Rating: Pulsed width limited by maximum junction temperature.
 b. Pulse test: pulse width $\leq 300\mu s$, duty cycle $\leq 2\%$.
 c. Guaranteed by design, not subject to production testing.

Switching Time Test Circuit and Waveforms



Soldering Methods For Products

1. Storage environment : Temperature=10°C~35°C, Humidity=65%±15%
2. Reflow soldering of surface mount devices

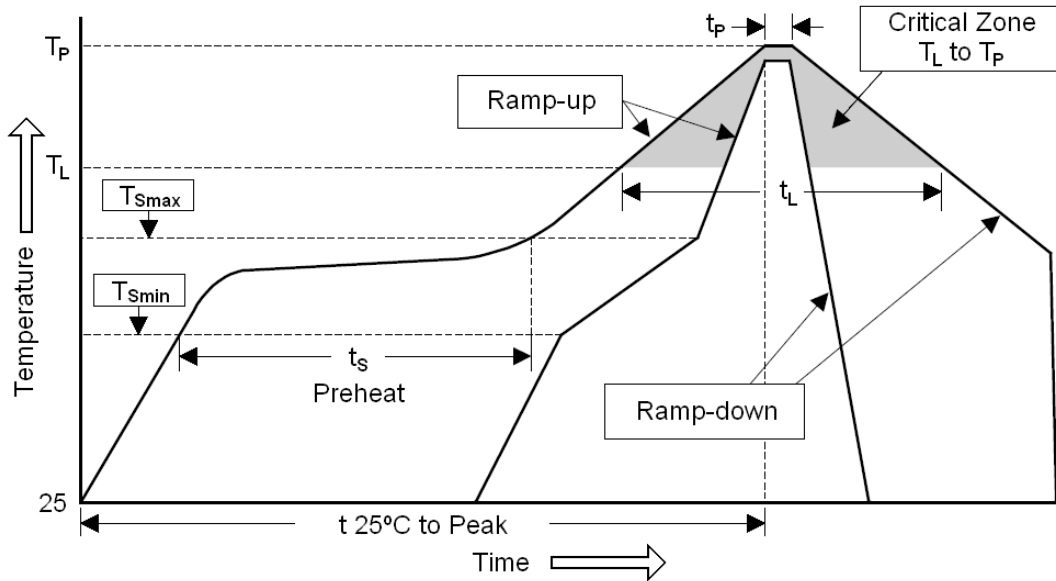


Figure : Temperature Profile

Profile Feature	Sn-Pb Eutectic Assembly	Pb-Free Assembly
Average ramp-up rate (T_L to T_P)	< 3°C/sec	< 3°C/sec
Preheat		
- Temperature Min (T_{Smin})	100°C	100°C
- Temperature Max (T_{Smax})	150°C	200°C
- Time (Min to Max) (t_s)	60 ~ 120 sec	60 ~ 180 sec
T_{Smax} to T_L		
- Ramp-up rate	< 3°C/sec	< 3°C/sec
Time maintained above:		
- Temperature (T_L)	183°C	217°C
- Time (t_L)	60 ~ 150 sec	60 ~ 150 sec
Peak Temperature (T_P)	240°C +0/-5°C	260°C +0/-5°C
Time within 5°C of actual Peak Temperature (t_P)	10 ~ 30 sec	20 ~ 40 sec
Ramp-down rate	< 6°C/sec	< 6°C/sec
Time 25°C to Peak Temperature	< 6 minutes	< 8 minutes

3. Flow (wave) soldering (solder dipping)

Product	Peak Temperature	Dipping Time
Pb devices	245°C ±5°C	5sec ±1sec
Pb-Free devices	260°C +0/-5°C	5sec ±1sec

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